C20 Rec'd PCT/PTO 02 MAY 2005 IN THE UNITED STATES PATENT AND TRADE

Appl. No.

: National Phase Entry of PCT/EP03/012099

Applicant

: SCHMID

Filed

: May 2, 2005

TC/A.U.

Examiner

: 2923-709

Docket No. Customer No.: 6449

Confirmation No. :

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

Sir:

In compliance with applicants duty of disclosure under 37 C.F.R. 1.56, enclosed is a copy of the International Search Report in the corresponding international application. The relevance of the references is noted in the International Search Report. We understand that the references have been forwarded by the International Bureau, and are available to the Examiner, but if the Examiner needs copies of any of the references, the Examiner is requested to advise counsel accordingly.

In the event that any fees are due with this paper, please charge our Deposit Account No. 02-2135.

Respectfully submitted,

By

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Attorney for Applicant Registration No. 22,980

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RBM/cb

INFORMATION DISCLOSURE			JC20 Register of Known		
	•			Application Number	NAND 10 53 3517
· ·				Filing Date	May 2, 2005
STATEMENT BY APPLICANT				First Named Inventor	Hans W. SCHMID
				Group Art Unit	
				Confirmation No.	
Sheet	1	of	2	Attorney Docket Number	2923-709

U.S. PATENT DOCUMENTS							
		U.S. Patent D	ocument	Name of Patentee or Applicant of Cited Document	Date of Publication		
Examiner Initials*	Cite No. ¹	Number Kind Code ² (if known)		of Cited Document	of Cited Document MM-DD-YYYY		
	1.	6,281,241	B1	Peter Elsner	8/28/01		
	2.	4,746,674	А	Walter Pierpaoli et al	5/24/88		
	3.	5,985,293	А	Lionel Breton et al	11/16/99		
				. 20.47			

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁴Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.

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	, v			Application Number	New Appl 533517	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Filing Date	May 2, 2005	
				First Named Inventor	Hans W. SCHMID	
				Group Art Unit		
				Examiner Name		
				Confirmation No.		
Sheet	2	of	2	Attorney Docket Number	2923-709	

			FOR	EIGN PAT	ENT DOCUMENTS		
Examiner Initials*	er Cite Office		Foreign Patent Docur Number⁴	ment Kind ⁵ (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	T ⁶
	4.	EP	0 867 181	A	Merkus Franciscus Wilhelmus HE	9/30/98	
	5.	DE	101 10 418	А	ASAT AG Applied Science & Tech	9/12/02	
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Examiner Signature	1	<u> </u>	<u> </u>	<u> </u>	Date Considered	1	<u> </u>

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.